

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/698,159	GHOSH ET AL.
Examiner	Art Unit	
Ellen C. Tran	2134	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
USPG, USPTO, EPO, JPO, OCR, DERWENT, IBM TECH DES	10/3/2006	ECT
NPL - IEEE XPLORE	10/3/2006	ECT
INTERFERENCE SEARCH - USPG PUB	10/3/2006	ECT
All claims were reviewed for possible 101 rejection by Examiner	10/3/2006	ECT

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
INTERFERENCE SEARCH		10/3/2006	ECT

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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

INVENTOR	Date	Exmr.
DBL PART	2 APR 64	ELT
US PTO		
USPC		
EPO		
JPO		
DERWENT		
IBM TECH AS		
CONSULTED w/ SPE		
CONSULTED 101 HELP PAGE		

INTERFERENCE SEARCHED

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